

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/609,132	BOECKLE ET AL.	
			Examiner	Art Unit	Page 1 of 1
			Louis K. Huynh	3721	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,140,756	08-1992	Iwaya et al.	118/57
	B	US-5,753,302	05-1998	Sun et al.	118/308
	C	US-6,471,096	10-2002	Dave, Rajesh N.	222/196
	D	US-6,684,917	02-2004	Zhu et al.	141/18
	E	US-6,764,695	07-2004	Watanabe et al.	424/465
	F	US-6,776,361	08-2004	Watanabe et al.	222/195
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.